## Notice of References Cited

2 1 Fe b

Application/Control No.

10/026,233

Examiner

Minh-Chau T. Pham

Applicant(s)/Patent Under
Reexamination
CHAU, YIU CHAU

Art Unit
Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	. A	US-5634888	06-1997	Henkin et al	601/148
	В	US-5097863	03-1992	McCann et al	137/504
	С	US-5823229	10-1998	Bertrand et al	137/614.2
	D	US-5989425	11-1999	Yonezawa et al	210/282
	E	US-6179130 B1	01-2001	Nguyen et al	210/424
	F	US-6258266 B1	07-2001	Riback et al	210/234
	G	US-6474155 B1	11-2002	Berkcan et al	73/204.23
	H	US-			
	-,	US-			
	7	US-			
	K	US-			
	۔	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.